

<p style="margin: 0;">Search Notes</p> 				<p style="margin: 0;">Application/Control No.</p> <p style="margin: 0;">10/790,880</p> <p style="margin: 0;">Examiner</p> <p style="margin: 0;">Denise Tran</p>	<p style="margin: 0;">Applicant(s)/Patent under Reexamination</p> <p style="margin: 0;">AKIYAMA ET AL.</p> <p style="margin: 0;">Art Unit</p> <p style="margin: 0;">2188</p>	
SEARCHED				SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
Class	Subclass	Date	Examiner		DATE	EXMR
				text search (USPAT, USPGPUB, USOCR, EPOAB, JPOAB, D ERWENT, IBM-TDB)	11/21/2008	DT
				711/5,118,170,128-129,104,144; 365/230.03,185.11 (text search only search history)	11/21/2008	DT
				711/103,105, 167; 365/189.01 (text search only search history)	11/21/2008	DT
				inventor name search	11/21/2008	DT
INTERFERENCE SEARCHED						
Class	Subclass	Date	Examiner			